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# N-Channel Power Trench<sup>®</sup> MOSFET 30 V, 16 A, 14.3 m $\Omega$

#### Features

- Max r<sub>DS(on)</sub> = 14.3 mΩ at V<sub>GS</sub> = 10 V, I<sub>D</sub> = 10.5 A
- Max r<sub>DS(on)</sub> = 22.5 mΩ at V<sub>GS</sub> = 4.5 V, I<sub>D</sub> = 8.3 A
- High performance technology for extremely low r<sub>DS(on)</sub>
- Termination is Lead-free and RoHS Compliant

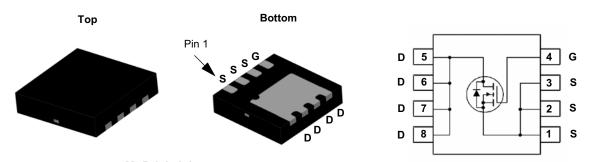


## **General Description**

This N-Channel MOSFET is produced using Fairchild Semiconductor's advanced Power Trench<sup>®</sup> process that has been especially tailored to minimize the on-state resistance. This device is well suited for Power Management and load switching applications common in Notebook Computers and Portable Battery Packs.

## Application

- High side in DC DC Buck Converters
- Notebook battery power management
- Load switch in Notebook





## MOSFET Maximum Ratings T<sub>A</sub> = 25 °C unless otherwise noted

Symbol	Parameter			Ratings	Units	
V <sub>DS</sub>	Drain to Source Voltage			30	V	
V <sub>GS</sub>	Gate to Source Voltage			±20	V	
	Drain Current -Continuous (Package limited)	T <sub>C</sub> = 25 °C		16		
I <sub>D</sub>	-Continuous (Silicon limited)	T <sub>C</sub> = 25 °C		34	Α	
	-Continuous	T <sub>A</sub> = 25 °C	(Note 1a)	10.5		
	-Pulsed			40		
P	Power Dissipation	T <sub>C</sub> = 25 °C		18	W	
P <sub>D</sub>	Power Dissipation	T <sub>A</sub> = 25 °C	(Note 1a)	2.3		
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Junction Temperature Range			-55 to +150	°C	

#### **Thermal Characteristics**

$R_{\theta JC}$	Thermal Resistance, Junction to Case	6.6	°C/W
$R_{ ext{ heta}JA}$	Thermal Resistance, Junction to Ambient (Note 1a)	53	C/VV

## Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity	
FDMC8882	FDMC8882	MLP 3.3x3.3	13 "	12 mm	3000 units	

May 2014

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units	
Off Chara	acteristics						
BV <sub>DSS</sub>	Drain to Source Breakdown Voltage	I <sub>D</sub> = 250 μA, V <sub>GS</sub> = 0 V	30			V	
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	$I_D = 250 \ \mu$ A, referenced to 25 °C		25		mV/°C	
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 24 V, V <sub>GS</sub> = 0 V T <sub>J</sub> = 125 °C			1 250	μA	
I <sub>GSS</sub>	Gate to Source Leakage Current	V <sub>GS</sub> = ±20 V, V <sub>DS</sub> = 0 V			±100	nA	
On Chara	octeristics						
V <sub>GS(th)</sub>	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}$ , $I_D = 250 \ \mu A$	1.2	1.9	2.5	V	
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	$I_D$ = 250 µA, referenced to 25 °C		-5		mV/°C	
r <sub>DS(on)</sub>	Static Drain to Source On Resistance	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 10.5 A		12.4	14.3	mΩ	
		$V_{GS}$ = 4.5 V, I <sub>D</sub> = 8.3 A		16.0	22.5		
		V <sub>GS</sub> = 10 V, I <sub>D</sub> = 10.5 A T <sub>J</sub> = 125 °C		17.4			
9 <sub>FS</sub>	Forward Transconductance	V <sub>DD</sub> = 5 V, I <sub>D</sub> = 10.5 A		33		S	
Dynamic	Characteristics						
C <sub>iss</sub>	Input Capacitance			710	945	pF	
C <sub>oss</sub>	Output Capacitance	— V <sub>DS</sub> = 15 V, V <sub>GS</sub> = 0 V, f = 1 MHz		140	185	pF	
C <sub>rss</sub>	Reverse Transfer Capacitance			90	135	pF	
R <sub>g</sub>	Gate Resistance			1.0		Ω	
Switching	g Characteristics						
t <sub>d(on)</sub>	Turn-On Delay Time			7	14	ns	
t <sub>r</sub>	Rise Time	V <sub>DD</sub> = 15 V, I <sub>D</sub> = 10.5 A,		3	10	ns	
t <sub>d(off)</sub>	Turn-Off Delay Time	$V_{GS}$ = 10 V, $R_{GEN}$ = 6 $\Omega$		17	30	ns	
t <sub>f</sub>	Fall Time			2	10	ns	
	Total Gate Charge	V <sub>GS</sub> = 0 V to 10 V		14	20	nC	
Q <sub>g(TOT)</sub>	Total Gate Charge	$V_{GS}$ = 0 V to 4.5 V $V_{DD}$ = 15 V		7	10	nC	
Q <sub>gs</sub>	Total Gate Charge	I <sub>D</sub> = 10.5 A		2.3		nC	
Qad	Gate to Drain "Miller" Charge			28		nC	

## **Drain-Source Diode Characteristics**

Gate to Drain "Miller" Charge

V	Source to Drain Diode Forward Voltage	V <sub>GS</sub> = 0 V, I <sub>S</sub> = 10.5 A (Note 2)	0.88	1.2	V
$V_{SD}$	Source to Drain Diode Torward Voltage	V <sub>GS</sub> = 0 V, I <sub>S</sub> = 1.9 A (Note 2)	0.76	1.2	v
t <sub>rr</sub>	Reverse Recovery Time	I <sub>E</sub> = 10.5 A, di/dt = 100 A/μs	16	28	ns
Q <sub>rr</sub>	Reverse Recovery Charge	$-1_{\rm F} = 10.5$ Å, di/dt = 100 Å/µs	4.4	10	nC

NOTES:

 $\mathsf{Q}_{\mathsf{gd}}$ 

1.  $R_{0JA}$  is determined with the device mounted on a 1 in<sup>2</sup> pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material.  $R_{0JC}$  is guaranteed by design while  $R_{\theta CA}$  is determined by the user's board design.

a. 53 °C/W when mounted on a 1 in<sup>2</sup> pad of 2 oz copper



2. Pulse Test: Pulse Width < 300  $\mu s,$  Duty cycle < 2.0 %.

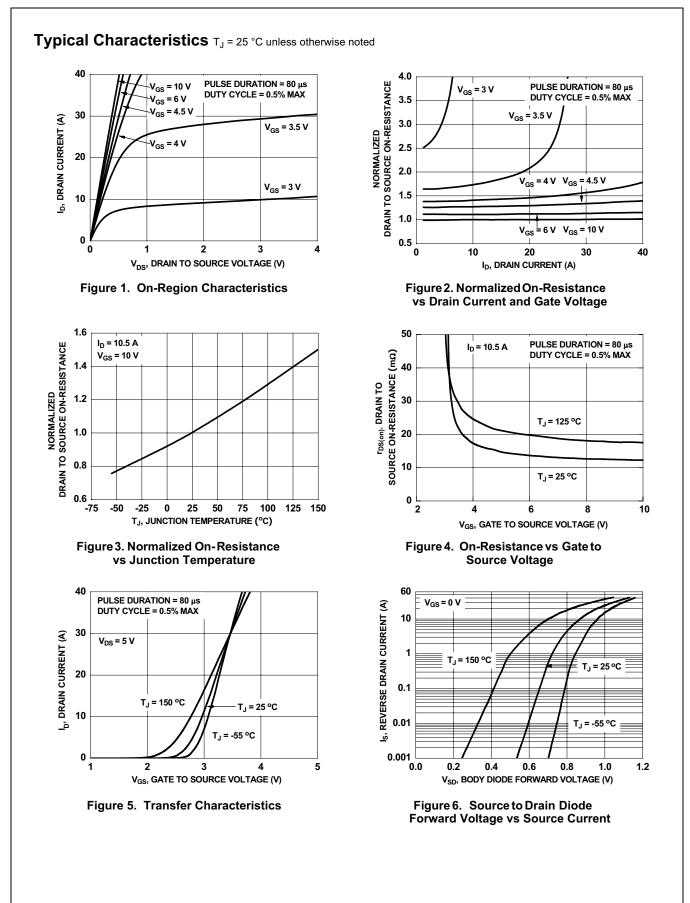
b.125 °C/W when mounted on a minimum pad of 2 oz copper

2.8



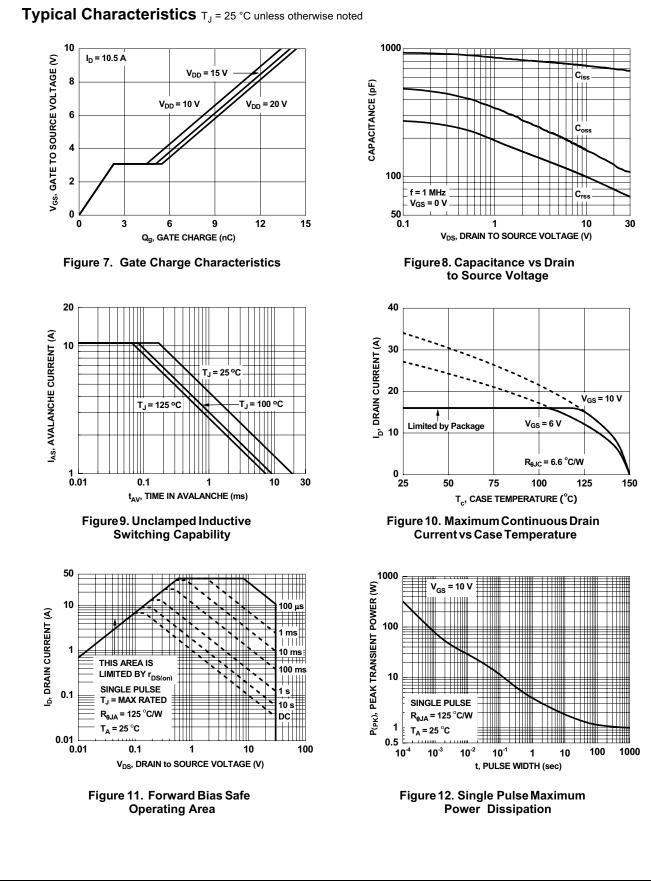
nC

FDMC8882 N-Channel Power Trench<sup>®</sup> MOSFET

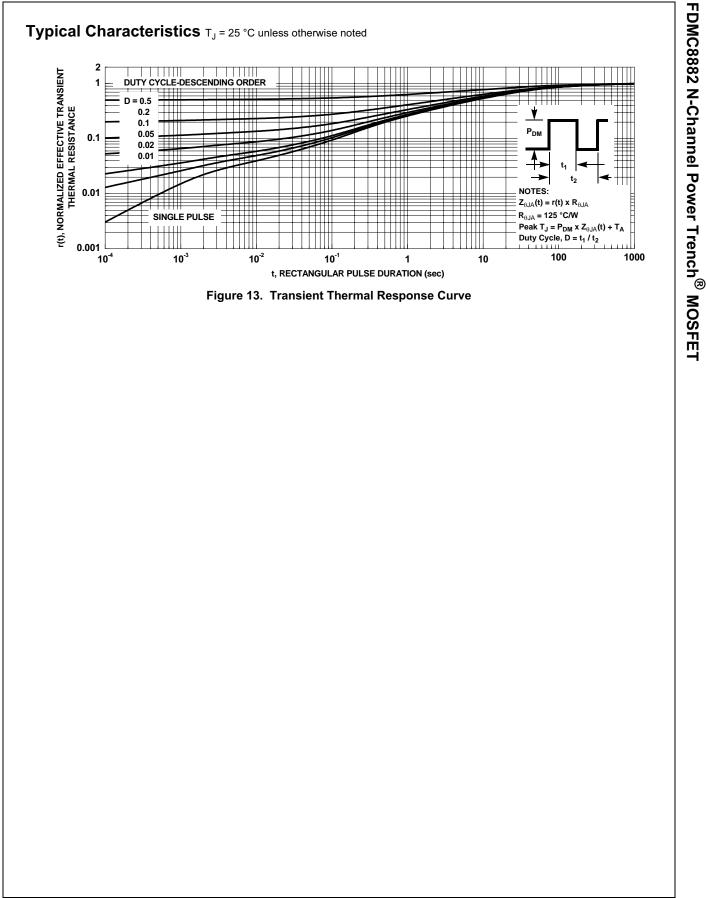


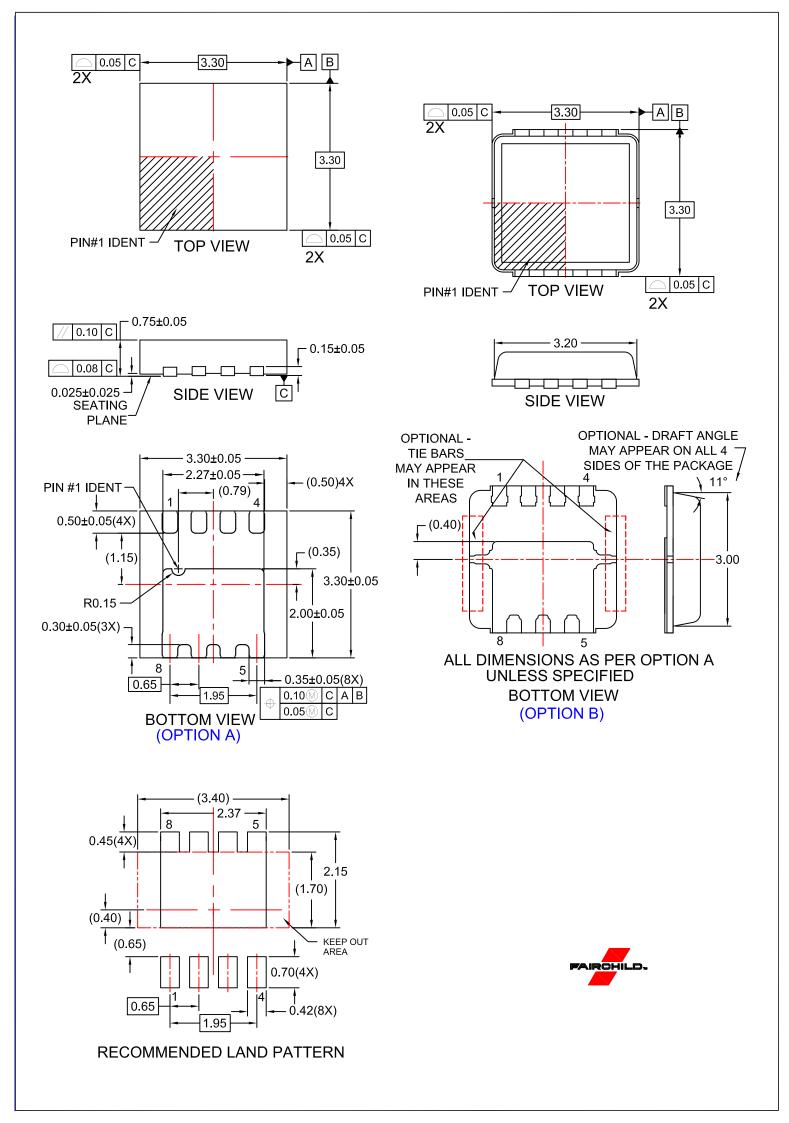
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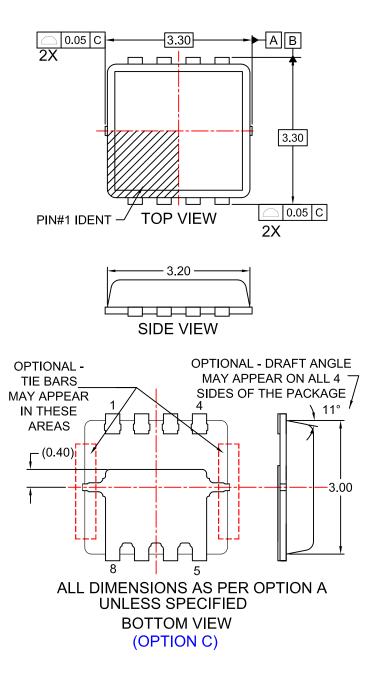




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#### NOTES:

- A. PACKAGE DOES NOT FULLY CONFORM TO JEDEC REGISTRATION MO-240.
- B. DIMENSIONS ARE IN MILLIMETERS.
- C. DIMENSIONS AND TOLERANCES PER ASME Y14.5M, 2009.
- D. LAND PATTERN RECOMMENDATION IS EXISTING INDUSTRY LAND PATTERN
- E. DIMENSIONS DO NOT INCLUDE BURRS OR MOLD FLASH. BURRS OR MOLD FLASH SHALL NOT EXCEED 0.10MM.
  F. DRAWING FILENAME: MKT-MLP08Wrev3.
- G. OPTION A SAWN MLP, OPTIONS B & C PUNCH MLP.





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